



X-ray and neutron diffraction of Er-hydride films

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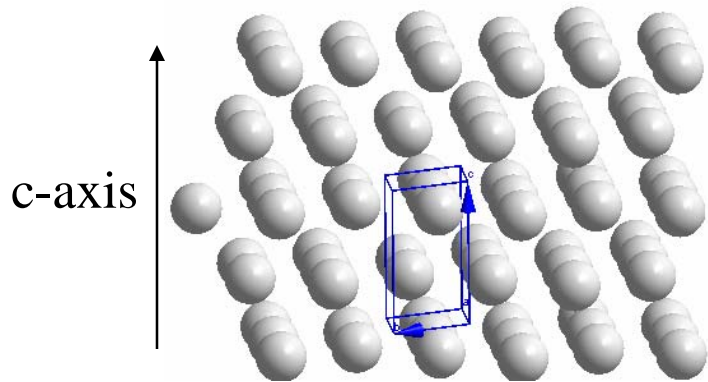




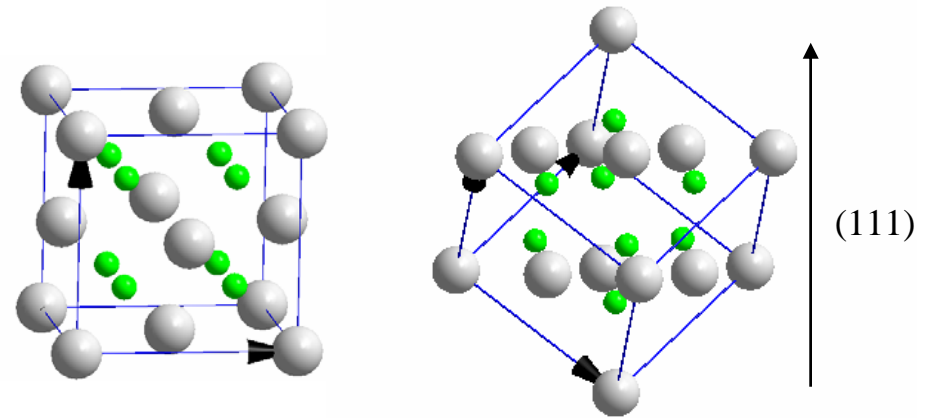
Outline

- Structures of hexagonal Er metal, ErH₂ fluorite, Molybdenum
- Texture issues and processing effects
- Idea of pole figure integration
- Promising neutron diffraction work

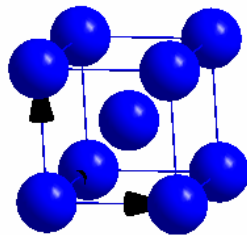
Structures of target and substrate have high symmetries



Er metal (HCP)



ErH₂ Fluorite (FCC)



Moly metal (BCC)

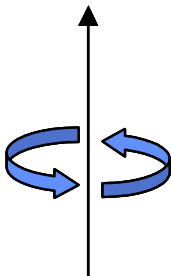
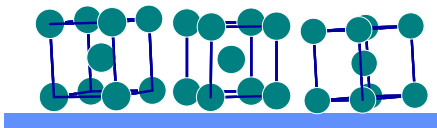
- Er layers shift from HCP to FCC during loading
- Large void in center of fluorite lattice

Texture definitions

Random grain orientation = no texture

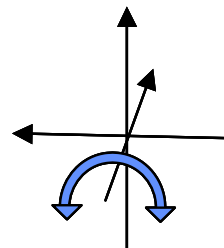
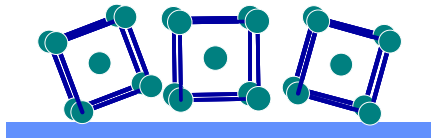
Fiber

out-of-plane (YES)
in-plane (NO)



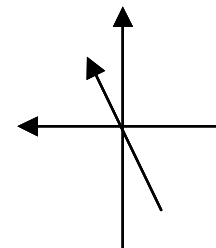
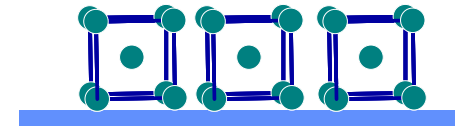
Rolling Texture

out-of-plane (YES)
in-plane: 1-dimension of
freedom, other fixed

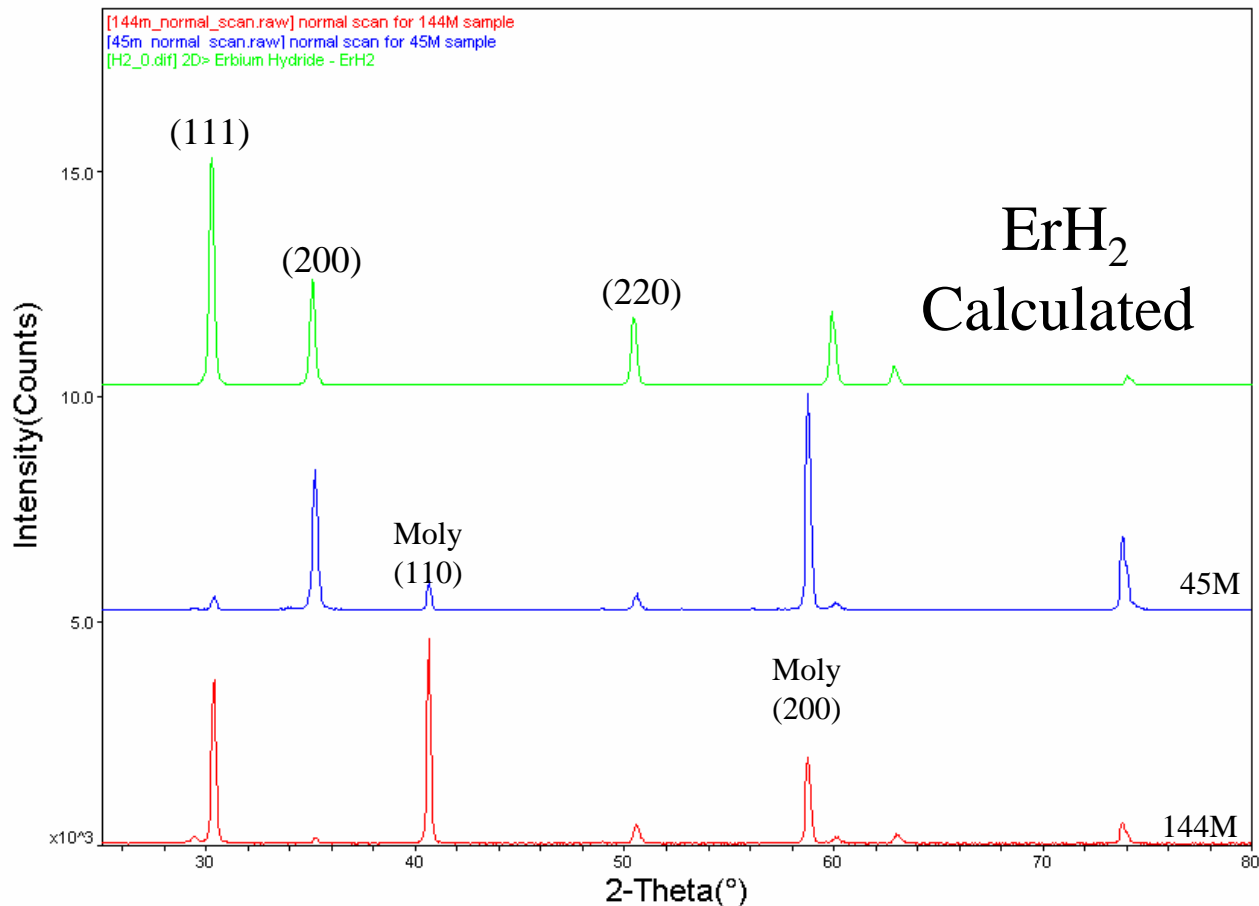


Bi-Axial

out-of-plane (YES)
in-plane (YES)



Typical θ - 2θ x-ray diffraction patterns reveal out-of-plane texture effects

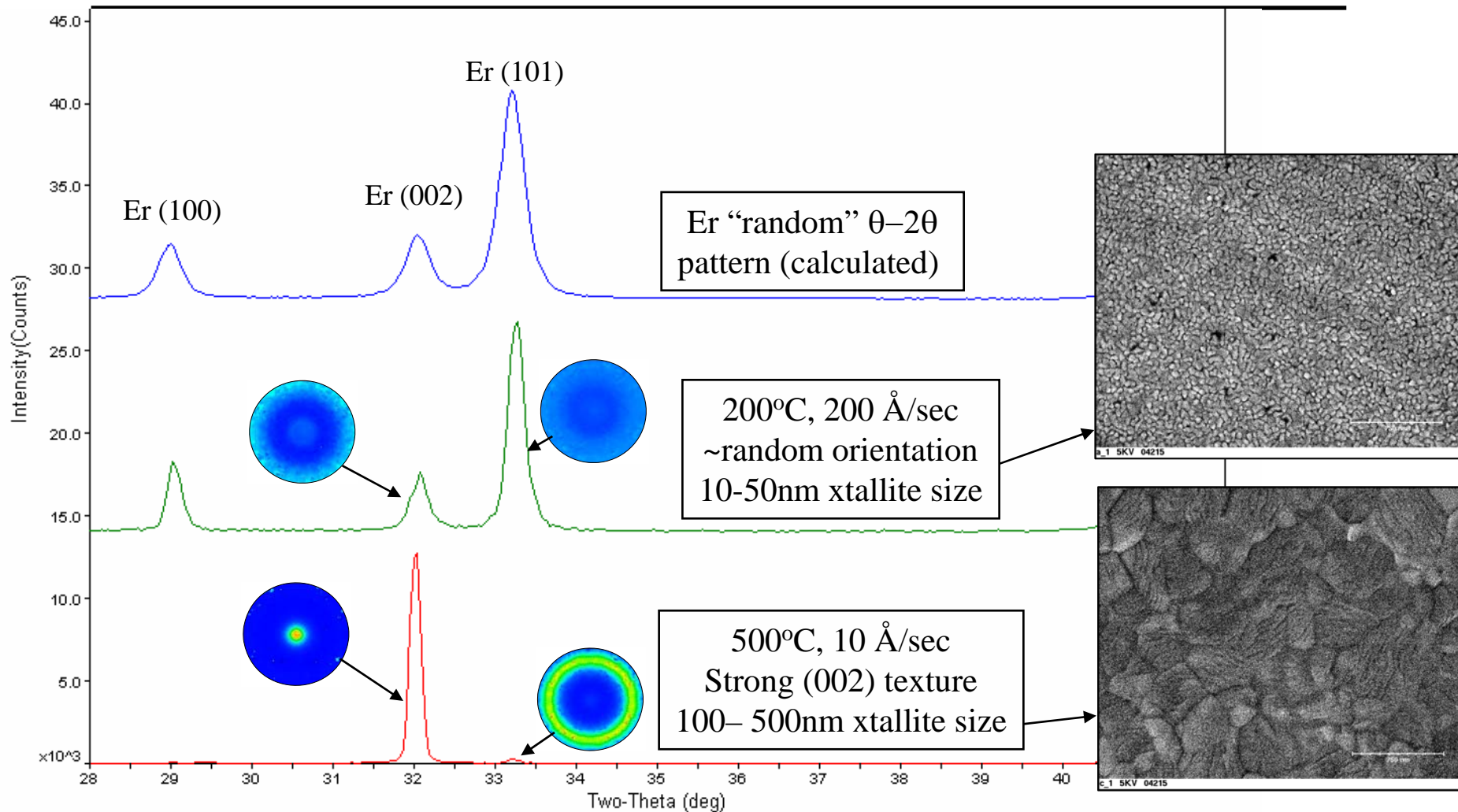




Several processing issues control texture of Er and ErH₂ films

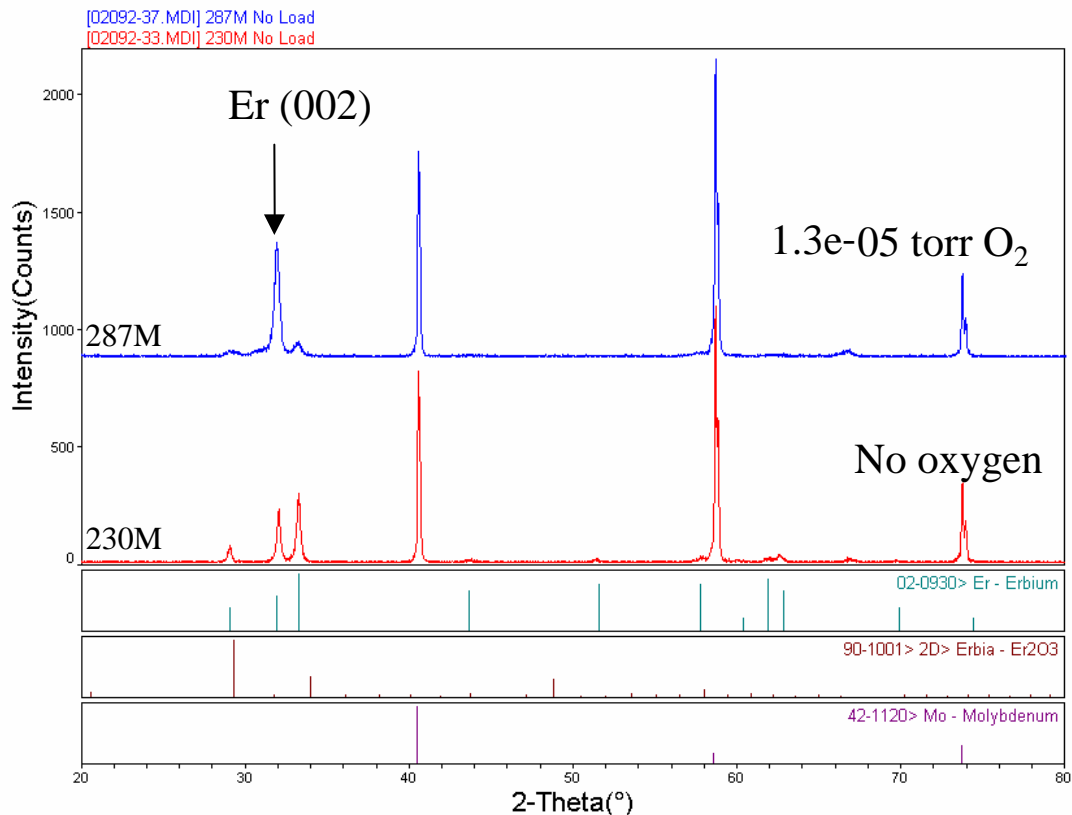
- Er deposition rate and/or temperature
 - Faster deposition rates encourage randomization
 - High deposition temperatures encourage grain growth
- Presence of oxygen
 - O₂ encourages Er (002) out-of-plane texture
- Texture of underlying Moly
 - Can dictate Er and ErD₂ texture via substrate templating

Deposition temperature/rate can dramatically alter resulting Er microstructure



Note: underlying Moly was not strongly textured

Presence of oxygen strongly affects texture of deposited Er film



200°C
10 Å/sec

Sample with oxygen shows strong (002) out-of-plane texture

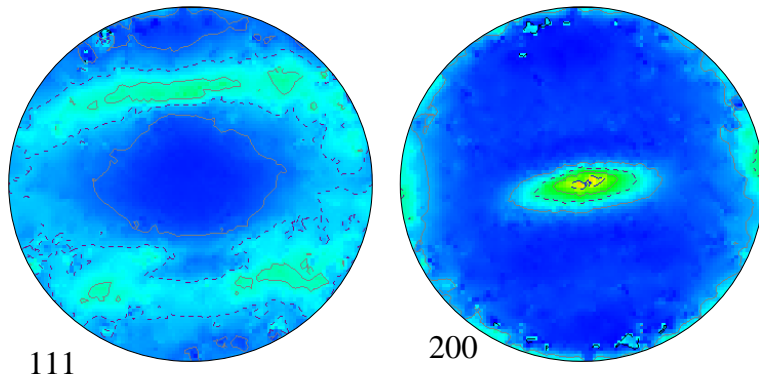
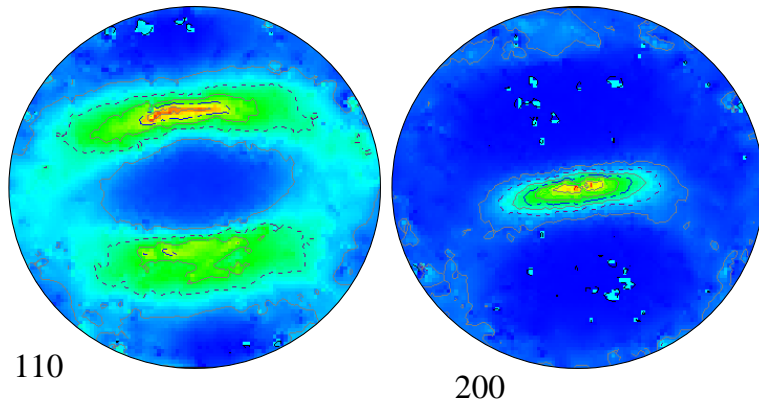
Substrate etching changes Moly texture - dictates ErD_2 grain orientation

Etched

450°C, 200 Å/sec

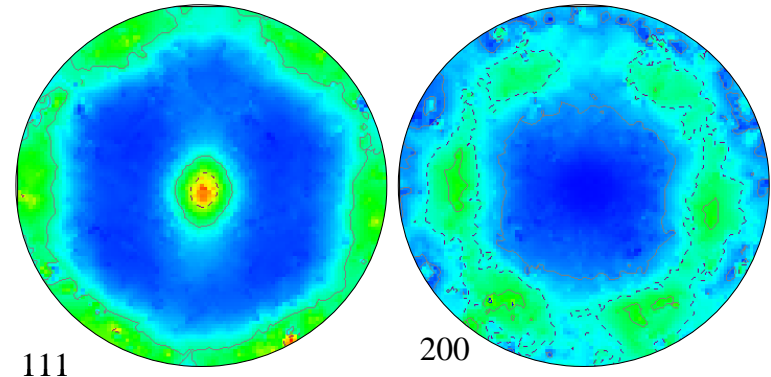
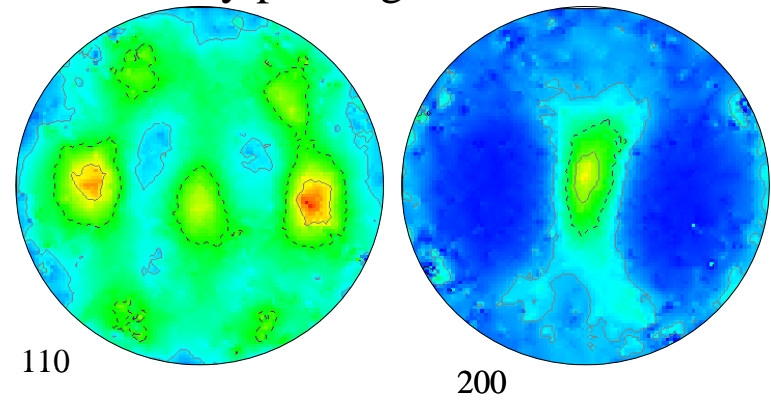
No Etch

Moly pole figures (15x random)




ErD_2 pole figures (5x random)

Moly pole figures (10x random)



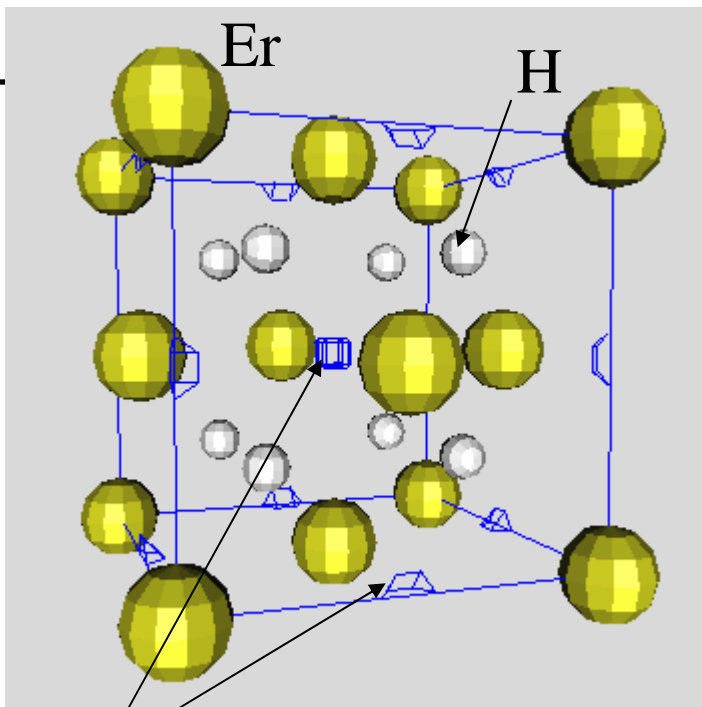
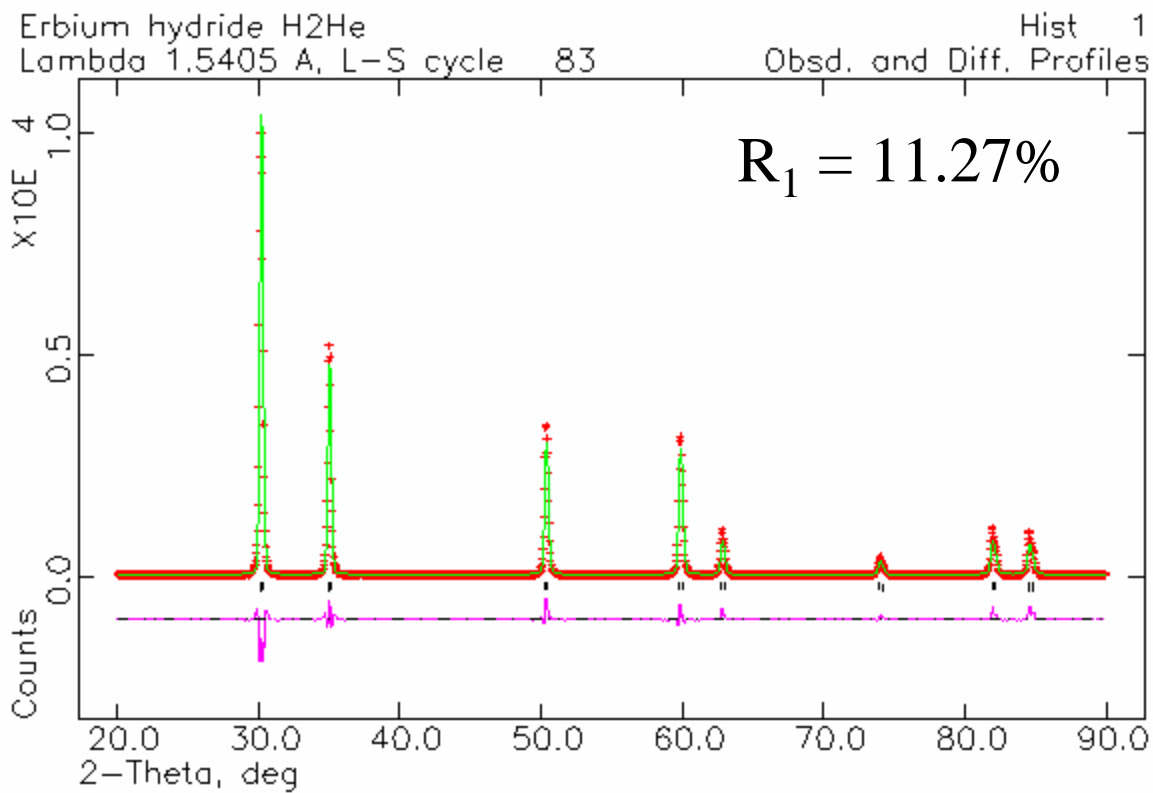
ErD_2 pole figures (5x random)



Can we use XRD data to model Helium in ErT_2 lattice?

- Generate calculated pattern with Helium atom present in octahedral (oct) site.
- Perform Rietveld structural-refinement on calculated pattern using fluorite structure (without He addition).
- Perform difference-Fourier analysis to see if He electron density is detectable.
- Correct peak intensities are crucial.

Calculated data for ErH_2 with He added at $(\frac{1}{2} \ \frac{1}{2} \ \frac{1}{2})$ site shows electron density in difference-Fourier mapping

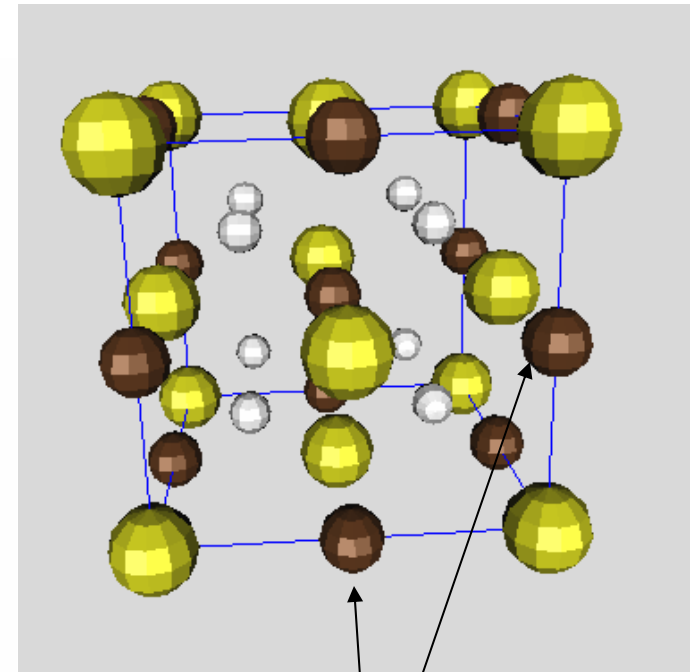
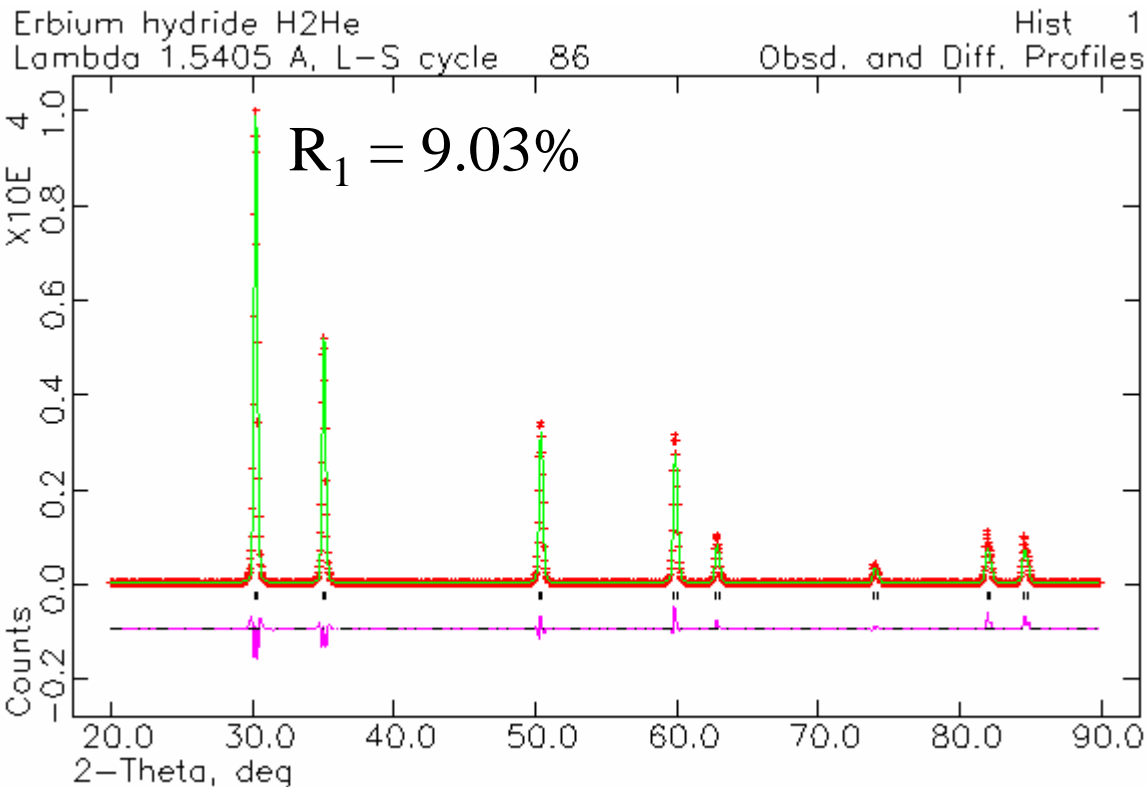


He detected in oct site via diff-Fourier

Contour plotted at 1.7

Rietveld refinement of calculated pattern


He was inserted into the model and refined
To ~1 or full occupancy (as expected)



He on oct site

Significant drop in
R value (-1.72%)

Final difference Fourier map
just shows background noise



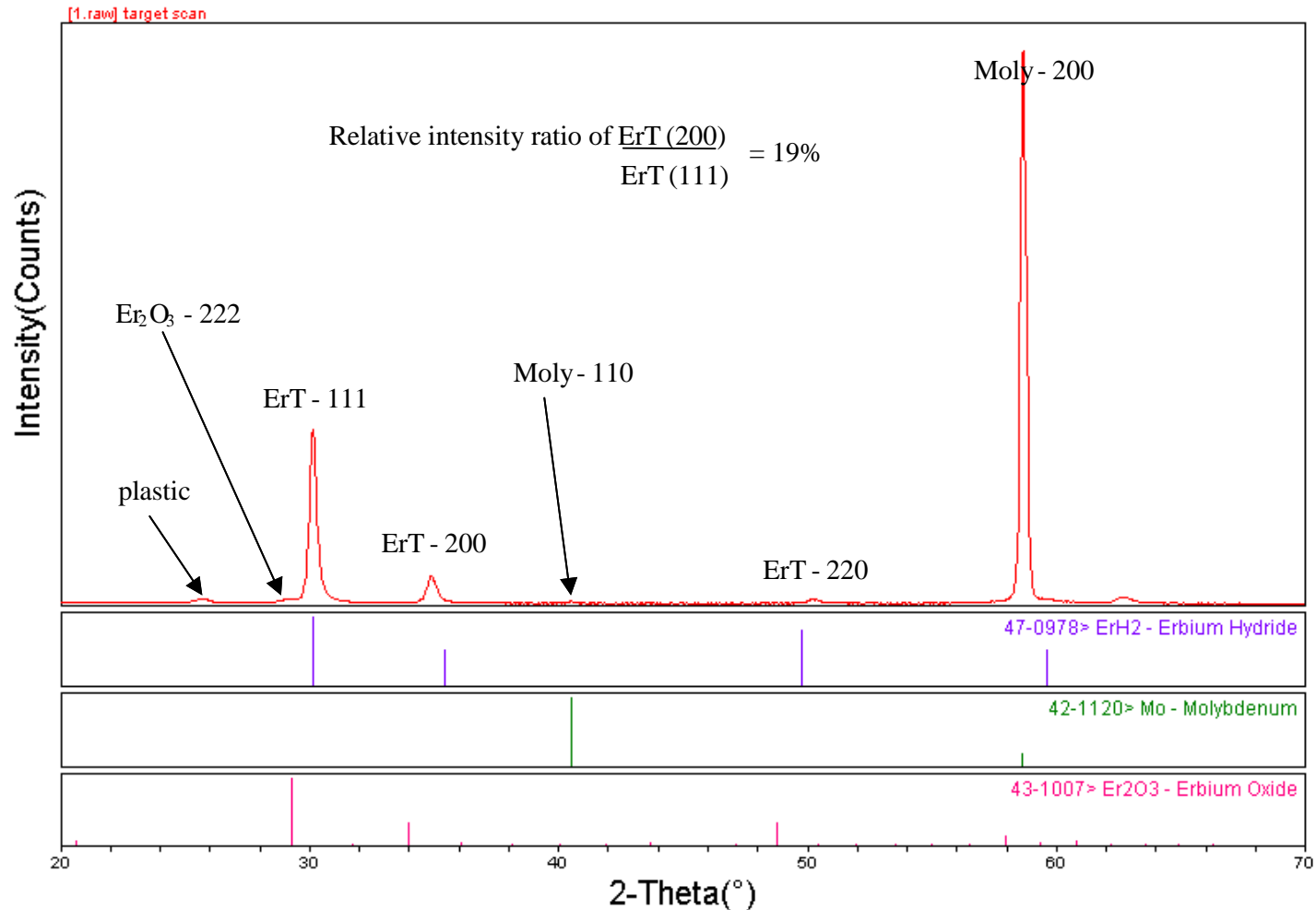
Accurate integrated intensities are crucial for He site occupancy measurements with XRD

	(111)	(200)
ErH ₂	100%	48%
ErH ₂ He	100%	54%

Biggest change of intensity:
6% increase in (200) with He addition at octahedral site

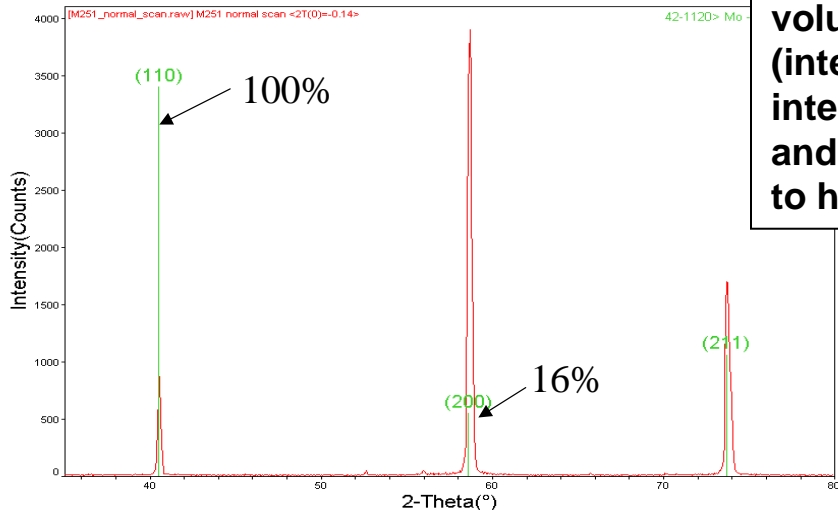
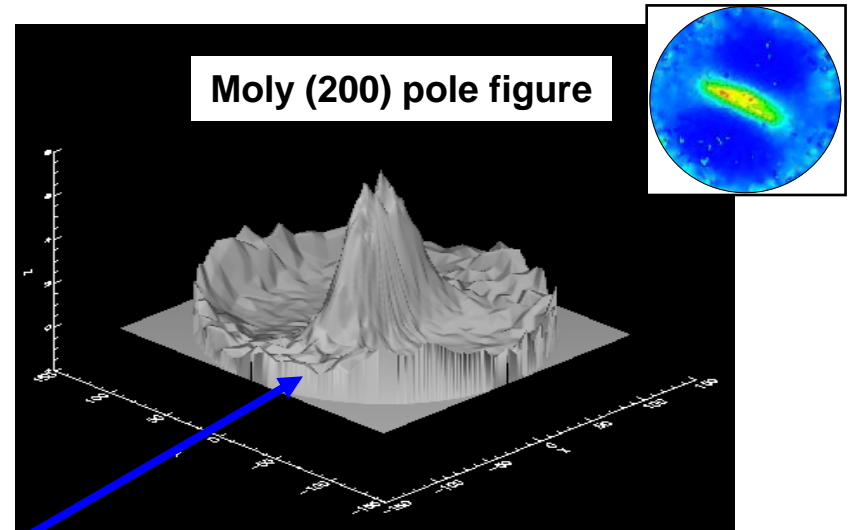
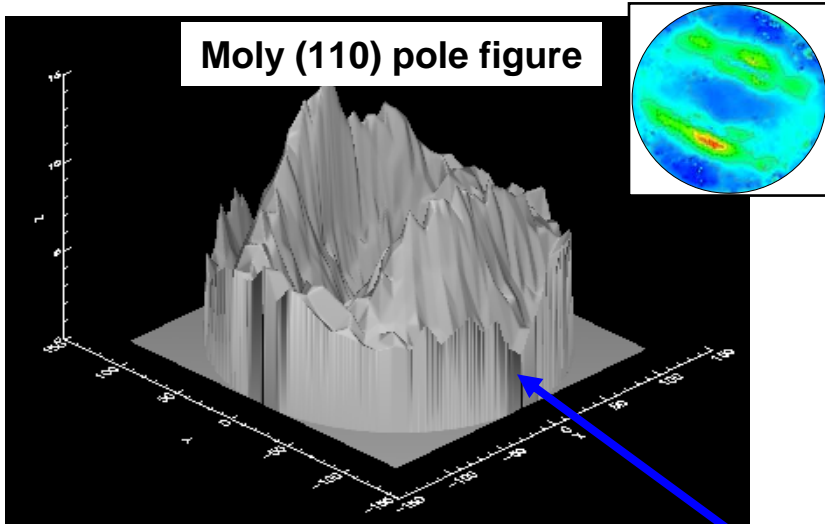
Challenge for this type of analysis – Texture

ErT₂ films on Moly show texture effects that bias intensities in standard $\theta-2\theta$ scans





Approach: Collect intensity of hkl in many different orientations (pole figure) to un-bias observed intensities due to texturing.

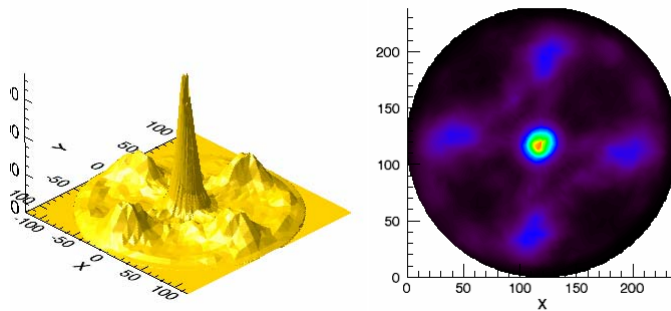


Pole figure volume (intensity) integrated and assigned to hkl

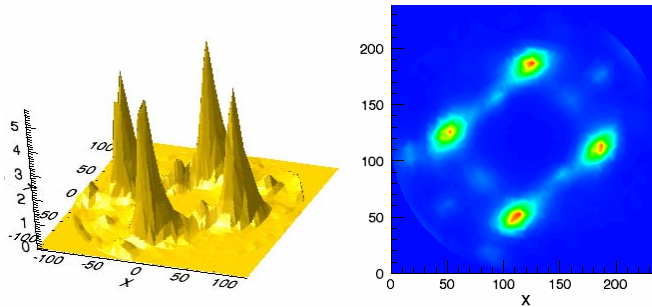
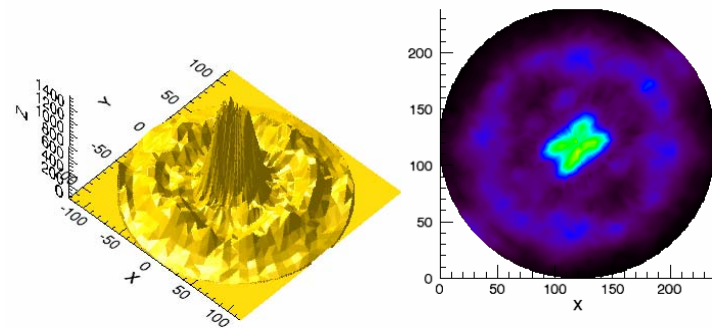
hkl	Obs. RI (%)	Exp. RI (%)	Cor. RI (%)
111	34	100	100
200	100	16	14

Pole figures for ErT_2 films show texturing effects and influence of Moly substrate

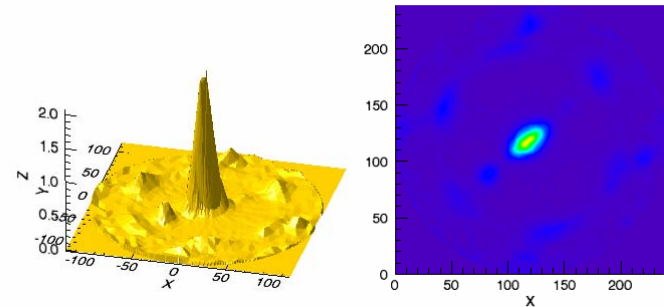
ErT_2 (111)



ErT_2 (200)



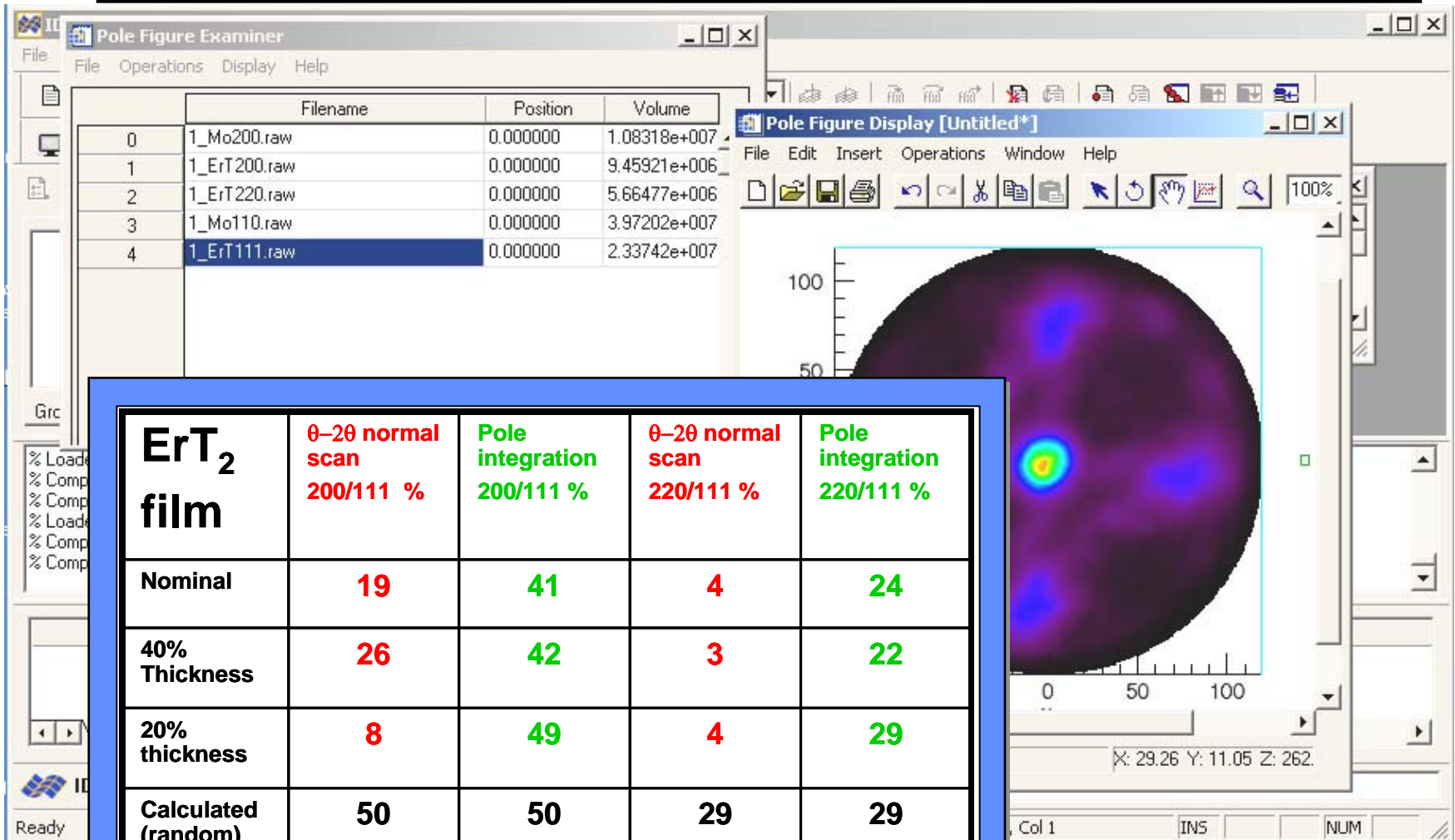
Moly (110)




Moly (200)

Bi-modal distribution of ErT_2 grain orientations

Relative intensity ratios derived from ErT_2 pole figures are much better estimates than $\theta-2\theta$ scans





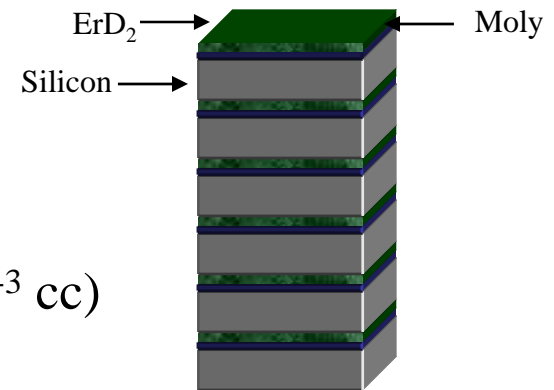
Neutron diffraction is being investigated as a diagnostic tool for ErD_2 films

- Advantage
 - Unlike x-rays, neutrons scatter well from deuterium (and tritium)
- Disadvantages
 - Need large volume of sample
 - Difficulties for analysis of thin films
 - Limited facilities and beam-time
 - Samples may activate

Recent neutron diffraction experiments at LANSCE /LANL show promise for structural analysis

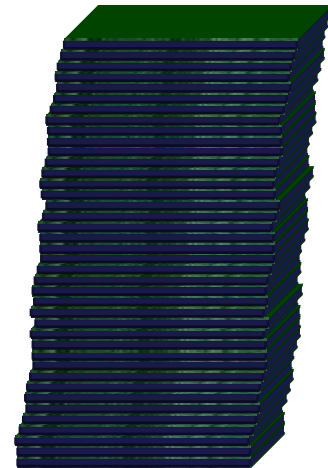
- First attempt: HIPD (2002)

- 6 ErD_2 films on moly-coated silicon ($\text{ErD}_2 = 0.2 \times 10^{-3} \text{ cc}$)
- Result...
 - need more ErD_2 signal, patterns swamped by Si peaks



- Second attempt: HIPPO (2003)

- 80 ErD_2 films deposited on 40 thin Moly foils ($\text{ErD}_2 = 3 \times 10^{-3} \text{ cc}$)
- Result...



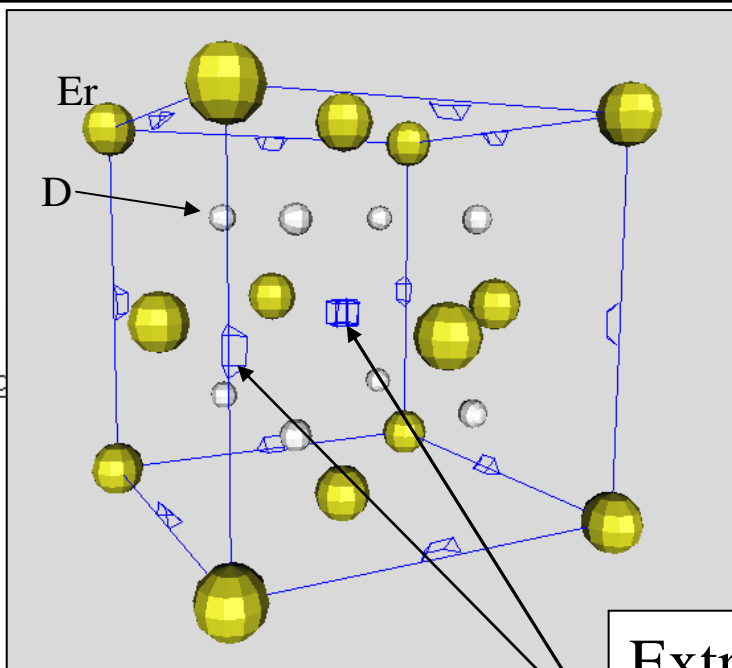
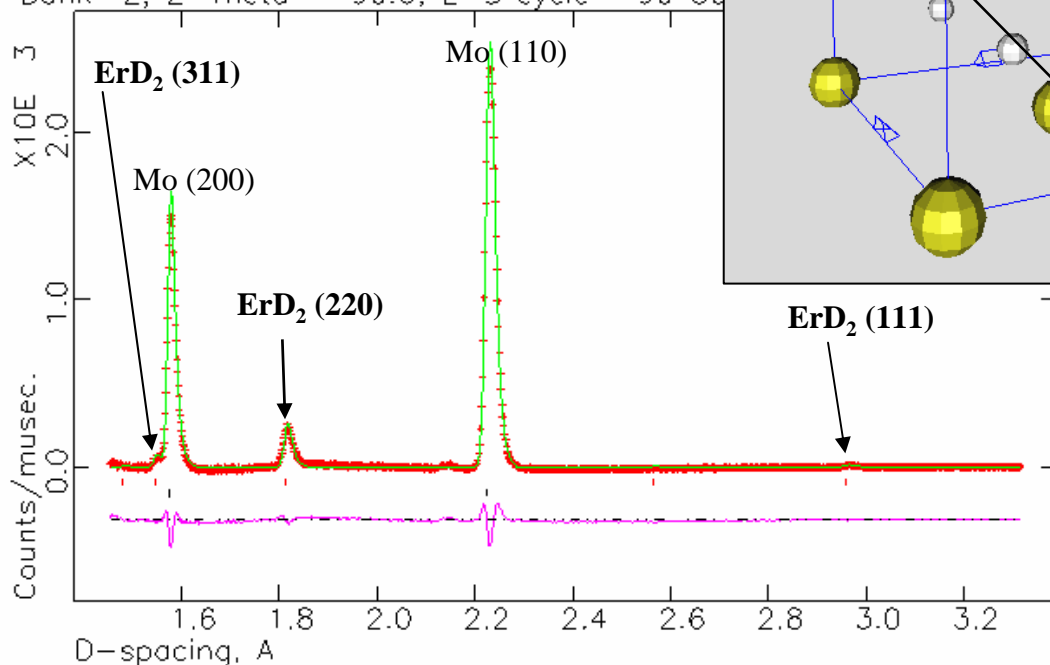
ErD₂ phase detected in neutron diffraction measurement: possible sensitivity to oct. site

Refined weight % ErD₂ = **2.1(3)%**

Expected weight % ErD₂ = 2.6 %

Refined ErD₂ lattice parameter, **a = 5.126(2) Å**

7320 ErD₂ on Moly
Bank 2, 2-Theta 90.0, L-S cycle 90 Ob



Density map at
60% of max scale

Extra density
at the $\frac{1}{2} \frac{1}{2} \frac{1}{2}$
site from diff-
Fourier



Summary

- ErD_2 and ErT_2 film microstructures are strongly effected by processing conditions.
- Both X-ray and neutron diffraction are being pursued to help diagnose structure/property issues regarding ErT_2 films and these correlations to He retention/release.
- Texture issues are great challenge for determination of site occupancy.
- Work on pole-figure-integration looks to have promise addressing texture issues in ErD_2 and ErT_2 films.



Acknowledgments

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